MOSFET – Power, Single, P-Channel, WDFN, 2X2 mm -20 V, -7.7 A

Features

- Recommended Replacement Device NTLUS3A40P
- WDFN Package Provides Exposed Drain Pad for Excellent Thermal Conduction
- 2x2 mm Footprint Same as SC-88 Package
- Lowest R_{DS(on)} Solution in 2x2 mm Package
- 1.5 V R_{DS(on)} Rating for Operation at Low Voltage Logic Level Gate Drive
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters (Buck and Boost Circuits)
- Optimized for Battery and Load Management Applications in Portable Equipment such as, Cell Phones, PDA's, Media Players, etc.
- High Side Load Switch

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Paran	neter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	-20	V	
Gate-to-Source Voltage	je		V_{GS}	±8.0	V
Continuous Drain	Steady	T _A = 25°C	I _D	-5.8	Α
Current (Note 1)	State	T _A = 85°C		-4.4	
	t ≤ 5 s	T _A = 25°C		-7.7	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.9	W
	t ≤ 5 s			3.3	
Continuous Drain		T _A = 25°C	I _D	-3.5	Α
Current (Note 2)	Steady	T _A = 85°C		-2.5	
Power Dissipation (Note 2)	State	T _A = 25°C	P _D	0.7	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	-23	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to 150	°C	
Source Current (Body Diode) (Note 2)		I _S	-2.8	Α	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

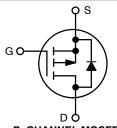
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size, (30 mm², 2 oz Cu).



ON Semiconductor®

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V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX (Note 1)
-20 V	40 mΩ @ -4.5 V	
	50 mΩ @ –2.5 V	-7.7 A
	75 mΩ @ –1.8 V	7.77
	200 mΩ @ –1.5 V	



P-CHANNEL MOSFET



WDFN6 CASE 506AP



MARKING

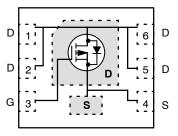
J8 = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



(Top View)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLJS3113PT1G	WDFN6	3000/Tape & Reel
NTLJS3113PTAG	(Pb-Free)	3000/ Tape & Neel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	65	
Junction-to-Ambient - t ≤ 5 s (Note 3)	$R_{ heta JA}$	38	°C/W
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	180	

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	ns	Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	$I_D = -250 \mu\text{A}$, Ref to 25°C			-10.1		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -16 V, V _{GS} = 0 V	$T_{J} = 25^{\circ}C$ $T_{J} = 85^{\circ}C$			-1.0 -10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±	· ·			±1.0	μΑ
ON CHARACTERISTICS (Note 5)	GGG	50 · do					
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = -2$	50 μA	-0.45	-0.67	-1.0	V
Negative Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J	40 BO B			2.68		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = -4.5, I _D = -3	V _{GS} = -4.5, I _D = -3.0 A		32	40	mΩ
		$V_{GS} = -2.5, I_D = -3$	3.0 A		44	50	1
		$V_{GS} = -1.8, I_D = -8$	2.0 A		67	75	1
		V _{GS} = -1.5, I _D = -1.8 A			90	200	
Forward Transconductance	9FS	V _{DS} = -16 V, I _D = -	-3.0 A		5.9		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	CE					
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -16 \text{ V}$			1329		pF
Output Capacitance	C _{OSS}				213		7
Reverse Transfer Capacitance	C _{RSS}				120		1
Total Gate Charge	Q _{G(TOT)}				13	15.7	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -16 \text{ V},$ $I_D = -3.0 \text{ A}$			1.5		1
Gate-to-Source Charge	Q_{GS}				2.2		1
Gate-to-Drain Charge	Q_{GD}				2.9		
Gate Resistance	R_{G}				14.4		Ω
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(ON)}				6.9		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{DD} =$	–10 V,		17.5		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = -3.0 \text{ A}, R_G = 3.0 \Omega$			60		
Fall Time	t _f				56.5		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Recovery Voltage	V_{SD}	V 0V 10 40A	T _J = 25°C		-0.78	-1.2	_ v
		$V_{GS} = 0 \text{ V, IS} = -1.0 \text{ A}$	T _J = 125°C		-0.67		
Reverse Recovery Time	t _{RR}				70.8	106	
Charge Time	ta	$V_{GS} = 0 \text{ V}, d_{ISD}/d_t = 1$	00 A/μs,		14.3		ns
Discharge Time	t _b	I _S = -1.0 A			56.4		1
Reverse Recovery Time	Q_{RR}				44		nC

- 5. Pulse Test: Pulse Width \leq 300 $\mu s,$ Duty Cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

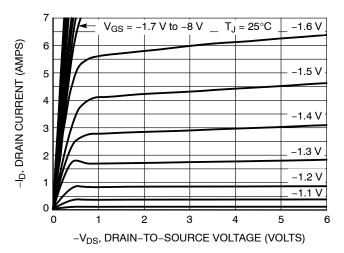


Figure 1. On-Region Characteristics

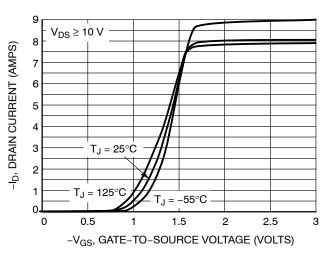


Figure 2. Transfer Characteristics

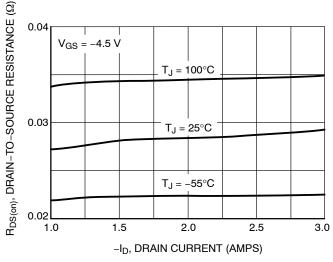


Figure 3. On-Resistance versus Drain Current

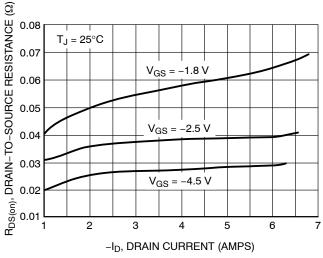


Figure 4. On-Resistance versus Drain Current and Gate Voltage

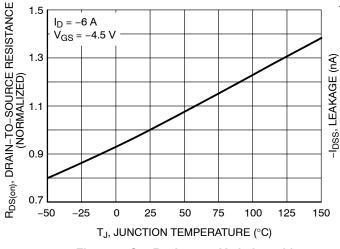


Figure 5. On–Resistance Variation with Temperature

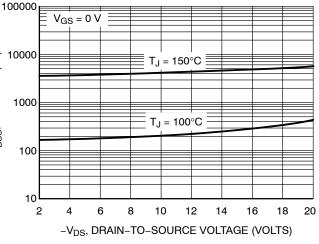
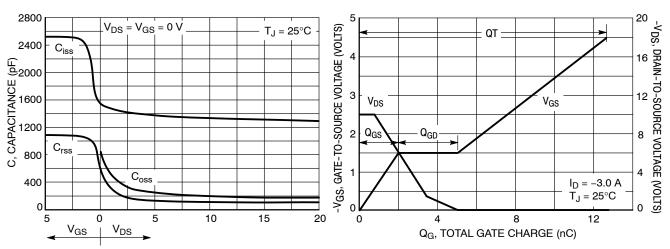


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 8. Gate-To-Source and Drain-To-Source
Voltage versus Total Charge

Figure 7. Capacitance Variation

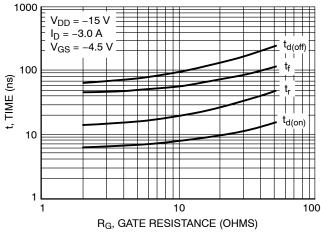


Figure 9. Resistive Switching Time Variation versus Gate Resistance

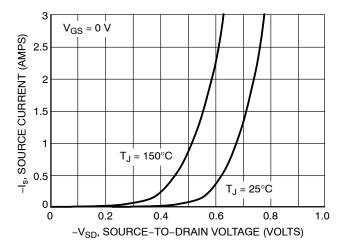


Figure 10. Diode Forward Voltage versus Current

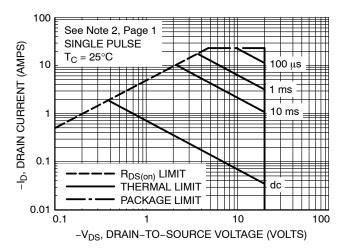


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

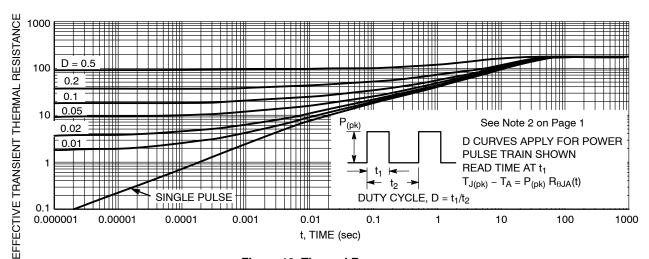


Figure 12. Thermal Response

Α

4X е

b1 6X

Ф

NOTE 5

0.10

b 6X

Ф

3 Ш

 \Box

PIN 1. COLLECTOR 2. COLLECTOR

EMITTER COLLECTOR

COLLECTOR

3. BASE

山口

BOTTOM VIEW

STYLE 2:

5.

В

Ε

C SEATING

0.10 C A

CAB

NOTE 3

С 0.05

С 0.05

В





SCALE 4:1

PIN ONE REFERENCE

2X 🗀 0.10

0.10 C

С

D2

7X \alpha 0.08

6X L

E2

STYLE 1:

5. DRAIN

PIN 1. DRAIN DRAIN 2. GATE

SOURCE

DRAIN 6.

0.10 C

WDFN6 2x2 CASE 506AP-01 **ISSUE B**

DATE 26 APR 2006

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20mm FROM TERMINAL.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- CENTER TERMINAL LEAD IS OPTIONAL. TERMINAL LEAD IS CONNECTED TO TERMINAL LEAD # 4.
- 2. PINS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.70	0.80		
A1	0.00	0.05		
A3	0.20	REF		
b	0.25	0.35		
b1	0.51	0.61		
D	2.00	BSC		
D2	1.00	1.20		
E	2.00 BSC			
E2	1.10	1.30		
е	0.65 BSC			
K	0.15 REF			
L	0.20	0.30		
L2	0.20	0.30		
J	0.27 REF			
J1	0.65 REF			

GENERIC MARKING DIAGRAM*

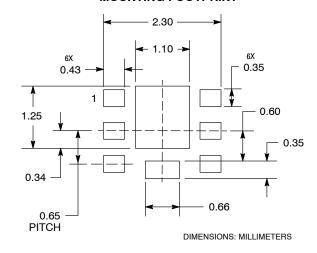


XX = Specific Device Code

= Date Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present.

SOLDERMASK DEFINED MOUNTING FOOTPRINT



DOCUMENT NUMBER:	98AON20860D	the Document Repository. COPY" in red.	
DESCRIPTION:	6 PIN WDFN 2X2, 0.65P		PAGE 1 OF 1

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